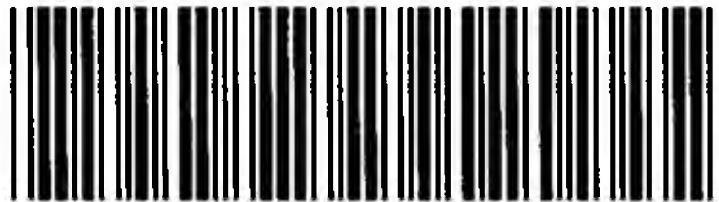


Search Notes



Application/Control No.

10/711,451

Examiner

Tri H. Phan

**Applicant(s)/Patent under
Reexamination**

BEDNASZ, KENNETH M.

Art Unit

2616

INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)